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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

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Details	
Product Status	Active
Core Processor	ARM® Cortex®-M0
Core Size	32-Bit Single-Core
Speed	24MHz
Connectivity	I ² C, IrDA, LINbus, Microwire, SmartCard, SPI, SSP, UART/USART
Peripherals	Brown-out Detect/Reset, CapSense, LCD, LVD, POR, PWM, WDT
Number of I/O	34
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 5.5V
Data Converters	A/D 8x12b SAR; D/A 2xIDAC
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	40-UFQFN Exposed Pad
Supplier Device Package	40-QFN (6x6)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c4125lqi-483t



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Functional Definition

CPU and Memory Subsystem

CPU

The Cortex-M0 CPU in PSoC 4100 is part of the 32-bit MCU subsystem, which is optimized for low power operation with extensive clock gating. It mostly uses 16-bit instructions and executes a subset of the Thumb-2 instruction set. This enables fully compatible binary upward migration of the code to higher performance processors such as the Cortex-M3 and M4, thus enabling upward compatibility. The Cypress implementation includes a hardware multiplier that provides a 32-bit result in one cycle. It includes a nested vectored interrupt controller (NVIC) block with 32 interrupt inputs and also includes a Wakeup Interrupt Controller (WIC), which can wake the processor up from Deep Sleep mode allowing power to be switched off to the main processor when the chip is in Deep Sleep mode. The Cortex-M0 CPU provides a Non-Maskable Interrupt input (NMI). which is made available to the user when it is not in use for system functions requested by the user.

The CPU also includes a debug interface, the serial wire debug (SWD) interface, which is a two-wire form of JTAG; the debug configuration used for PSoC 4100 has four break-point (address) comparators and two watchpoint (data) comparators.

Flash

PSoC 4100 has a flash module with a flash accelerator tightly coupled to the CPU to improve average access times from the flash block. The flash block is designed to deliver 0 wait-state (WS) access time at 24 MHz. Part of the flash module can be used to emulate EEPROM operation if required.

The PSoC 4200 Flash supports the following flash protection modes at the memory subsystem level:

- Open: No Protection. Factory default mode in which the product is shipped.
- Protected: User may change from Open to Protected. This mode disables Debug interface accesses. The mode can be set back to Open but only after completely erasing the Flash.
- Kill: User may change from Open to Kill. This mode disables all Debug accesses. The part cannot be erased externally, thus obviating the possibility of partial erasure by power interruption and potential malfunction and security leaks. This is an irrecvocable mode.

In addition, row-level Read/Write protection is also supported to prevent inadvertent Writes as well as selectively block Reads. Flash Read/Write/Erase operations are always available for internal code using system calls.

SRAM

SRAM memory is retained during Hibernate.

SROM

A supervisory ROM that contains boot and configuration routines is provided.

System Resources

Power System

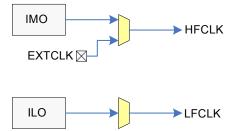
The power system is described in detail in the section Power on page 15. It provides assurance that voltage levels are as required for each respective mode and either delay mode entry (on power-on reset (POR), for example) until voltage levels are as required for proper function or generate resets (brown-out detect (BOD)) or interrupts (low-voltage detect (LVD)). The PSoC 4100 operates with a single external supply over the range of 1.71 V to 5.5 V and has five different power modes, transitions between which are managed by the power system. PSoC 4100 provides Sleep, Deep Sleep, Hibernate, and Stop low-power modes.

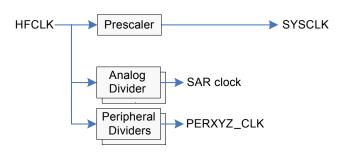
Clock System

The PSoC 4100 clock system is responsible for providing clocks to all subsystems that require clocks and for switching between different clock sources without glitching. In addition, the clock system ensures that no metastable conditions occur.

The clock system for PSoC 4100 consists of the internal main oscillator (IMO) and the internal low-power oscillator (ILO) and provision for an external clock.

Figure 3. PSoC 4100 MCU Clocking Architecture





The HFCLK signal can be divided down (see PSoC 4100 MCU Clocking Architecture) to generate synchronous clocks for the analog and digital peripherals. There are a total of 12 clock dividers for PSoC 4100, each with 16-bit divide capability. The analog clock leads the digital clocks to allow analog events to occur before digital clock-related noise is generated. The 16-bit capability allows a lot of flexibility in generating fine-grained frequency values and is fully supported in PSoC Creator.



IMO Clock Source

The IMO is the primary source of internal clocking in the PSoC 4100. It is trimmed during testing to achieve the specified accuracy. Trim values are stored in nonvolatile latches (NVL). Additional trim settings from flash can be used to compensate for changes. The IMO default frequency is 24 MHz and it can be adjusted between 3 MHz to 24 MHz in steps of 1 MHz. The IMO tolerance with Cypress-provided calibration settings is ±2%.

ILO Clock Source

The ILO is a very low power oscillator, which is primarily used to generate clocks for peripheral operation in Deep Sleep mode. ILO-driven counters can be calibrated to the IMO to improve accuracy. Cypress provides a software component, which does the calibration.

Watchdog Timer

A watchdog timer is implemented in the clock block running from the ILO; this allows watchdog operation during Deep Sleep and generates a watchdog reset if not serviced before the timeout occurs. The watchdog reset is recorded in the Reset Cause register.

Reset

PSoC 4100 can be reset from a variety of sources including a software reset. Reset events are asynchronous and guarantee reversion to a known state. The reset cause is recorded in a register, which is sticky through reset and allows software to determine the cause of the reset. An XRES pin is reserved for external reset to avoid complications with configuration and multiple pin functions during power-on or reconfiguration. The XRES pin has an internal pull-up resistor that is always enabled.

Voltage Reference

The PSoC 4100 reference system generates all internally required references. A 1% voltage reference spec is provided for the 12-bit ADC. To allow better signal to noise ratios (SNR) and better absolute accuracy, it is possible to bypass the internal reference using a GPIO pin or to use an external reference for the SAR.

Analog Blocks

12-bit SAR ADC

The 12-bit 806 ksps SAR ADC can operate at a maximum clock rate of 14.5 MHz and requires a minimum of 18 clocks at that frequency to do a 12-bit conversion.

The block functionality is augmented for the user by adding a reference buffer to it (trimmable to $\pm 1\%$) and by providing the choice (for the PSoC 4100 case) of three internal voltage references: $V_{DD},\,V_{DD}/2,\,$ and V_{REF} (nominally 1.024 V) as well as an external reference through a GPIO pin. The sample-and-hold (S/H) aperture is programmable allowing the gain bandwidth requirements of the amplifier driving the SAR inputs, which determine its settling time, to be relaxed if required. System performance will be 65 dB for true 12-bit precision providing appropriate references are used and system noise levels permit. To improve performance in noisy conditions, it is possible to provide an external bypass (through a fixed pin location) for the internal reference amplifier.

The SAR is connected to a fixed set of pins through an 8-input sequencer. The sequencer cycles through selected channels autonomously (sequencer scan) and does so with zero switching overhead (that is, aggregate sampling bandwidth is equal to 806 ksps whether it is for a single channel or distributed over several channels). The sequencer switching is effected through a state machine or through firmware driven switching. A feature provided by the sequencer is buffering of each channel to reduce CPU interrupt service requirements. To accommodate signals with varying source impedance and frequency, it is possible to have different sample times programmable for each channel. Also, signal range specification through a pair of range registers (low and high range values) is implemented with a corresponding out-of-range interrupt if the digitized value exceeds the programmed range; this allows fast detection of out-of-range values without the necessity of having to wait for a sequencer scan to be completed and the CPU to read the values and check for out-of-range values in software.

The SAR is able to digitize the output of the on-board temperature sensor for calibration and other temperature-dependent functions. The SAR is not available in Deep Sleep and Hibernate modes as it requires a high-speed clock (up to 18 MHz). The SAR operating range is 1.71 V to 5.5 V.

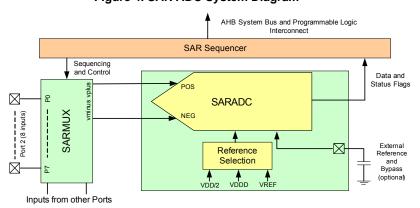


Figure 4. SAR ADC System Diagram



Two Opamps (CTBm Block)

PSoC 4100 has two opamps with Comparator modes which allow most common analog functions to be performed on-chip eliminating external components; PGAs, voltage buffers, filters, trans-impedance amplifiers, and other functions can be realized with external passives saving power, cost, and space. The on-chip opamps are designed with enough bandwidth to drive the S/H circuit of the ADC without requiring external buffering.

Temperature Sensor

PSoC 4100 has one on-chip temperature sensor This consists of a diode, which is biased by a current source that can be disabled to save power. The temperature sensor is connected to the ADC, which digitizes the reading and produces a temperature value using Cypress supplied software that includes calibration and linearization.

Low-power Comparators

PSoC 4100 has a pair of low-power comparators, which can also operate in the Deep Sleep and Hibernate modes. This allows the analog system blocks to be disabled while retaining the ability to monitor external voltage levels during low-power modes. The comparator outputs are normally synchronized to avoid metastability unless operating in an asynchronous power mode (Hibernate) where the system wake-up circuit is activated by a comparator switch event.

Fixed Function Digital

Timer/Counter/PWM Block (TCPWM)

The TCPWM block consists of four 16-bit counters with user-programmable period length. There is a Capture register to record the count value at the time of an event (which may be an I/O event), a period register which is used to either stop or auto-reload the counter when its count is equal to the period register, and compare registers to generate compare value signals which are used as PWM duty cycle outputs. The block also provides true and complementary outputs with programmable offset between them to allow use as deadband programmable complementary PWM outputs. It also has a Kill input to force outputs to a predetermined state; for example, this is used in motor drive systems when an overcurrent state is indicated and the PWMs driving the FETs need to be shut off immediately with no time for software intervention.

Serial Communication Blocks (SCB)

The PSoC 4100 has two SCBs, which can each implement an I^2 C, UART, or SPI interface.

I²C Mode: The hardware I²C block implements a full multi-master and slave interface (it is capable of multimaster arbitration). This block is capable of operating at speeds of up to 1 Mbps (Fast Mode Plus) and has flexible buffering options to reduce interrupt overhead and latency for the CPU. The FIFO mode is available in all channels and is very useful in the absence of DMA.

The I²C peripheral is compatible with the I²C Standard-mode, Fast-mode, and Fast-Mode Plus devices as defined in the NXP I²C-bus specification and user manual (UM10204). The I²C bus I/O is implemented with GPIO in open-drain modes. The I²C bus uses open-drain drivers for clock and data with pull-up resistors on the bus for clock and data connected to all nodes. The required Rise and Fall times for different I²C speeds are guaranteed by using appropriate pull-up resistor values depending on VDD, Bus Capacitance, and resistor tolerance. For detailed information on how to calculate the optimum pull-up resistor value for your design, refer to the UM10204 I2C bus specification and user manual (the latest revision is available at www.nxp.com).

PSoC 4100 is not completely compliant with the I²C spec in the following respects:

- GPIO cells are not overvoltage-tolerant and, therefore, cannot be hot-swapped or powered up independently of the rest of the I²C system.
- Fast-mode Plus has an I_{OL} specification of 20 mA at a V_{OL} of 0.4 V. The GPIO cells can sink a maximum of 8-mA I_{OL} with a V_{OL} maximum of 0.6 V.
- Fast-mode and Fast-mode Plus specify minimum Fall times, which are not met with the GPIO cell; Slow strong mode can help meet this spec depending on the Bus Load.
- When the SCB is an I²C master, it interposes an IDLE state between NACK and Repeated Start; the I²C spec defines Bus free as following a Stop condition so other Active Masters do not intervene but a Master that has just become activated may start an Arbitration cycle.
- When the SCB is in I²C slave mode, and Address Match on External Clock is enabled (EC_AM = 1) along with operation in the internally clocked mode (EC_OP = 0), then its I²C address must be even.

UART Mode: This is a full-feature UART operating at up to 1 Mbps. It supports automotive single-wire interface (LIN), infrared interface (IrDA), and SmartCard (ISO7816) protocols, all of which are minor variants of the basic UART protocol. In addition, it supports the 9-bit multiprocessor mode that allows addressing of peripherals connected over common RX and TX lines. Common UART functions such as parity error, break detect, and frame error are supported. An 8-deep FIFO allows much greater CPU service latencies to be tolerated.

SPI Mode: The SPI mode supports full Motorola SPI, TI SSP (essentially adds a start pulse used to synchronize SPI Codecs), and National Microwire (half-duplex form of SPI). The SPI block can use the FIFO.



GPIO

PSoC 4100 has 36 GPIOs. The GPIO block implements the following:

- Eight drive strength modes:
- ☐ Analog input mode (input and output buffers disabled)
- □ Input only
- □ Weak pull-up with strong pull-down
- ☐ Strong pull-up with weak pull-down
- □ Open drain with strong pull-down
- □ Open drain with strong pull-up
- ☐ Strong pull-up with strong pull-down
- □ Weak pull-up with weak pull-down
- Input threshold select (CMOS or LVTTL).
- Individual control of input and output buffer enabling/disabling in addition to the drive strength modes.
- Hold mode for latching previous state (used for retaining I/O state in Deep Sleep mode and Hibernate modes).
- Selectable slew rates for dV/dt related noise control to improve EMI.

The pins are organized in logical entities called ports, which are 8-bit in width. During power-on and reset, the blocks are forced to the disable state so as not to crowbar any inputs and/or cause excess turn-on current. A multiplexing network known as a high-speed I/O matrix is used to multiplex between various signals that may connect to an I/O pin. Pin locations for fixed-function peripherals are also fixed to reduce internal multiplexing complexity.

Data output and pin state registers store, respectively, the values to be driven on the pins and the states of the pins themselves. Every I/O pin can generate an interrupt if so enabled and each I/O port has an interrupt request (IRQ) and interrupt service routine (ISR) vector associated with it (5 for PSoC 4100 since it has 4.5 ports).

Special Function Peripherals

LCD Segment Drive

PSoC 4100 has an LCD controller which can drive up to four commons and up to 32 segments. It uses full digital methods to drive the LCD segments requiring no generation of internal LCD voltages. The two methods used are referred to as digital correlation and PWM.

Digital correlation pertains to modulating the frequency and levels of the common and segment signals to generate the highest RMS voltage across a segment to light it up or to keep the RMS signal zero. This method is good for STN displays but may result in reduced contrast with TN (cheaper) displays.

PWM pertains to driving the panel with PWM signals to effectively use the capacitance of the panel to provide the integration of the modulated pulse-width to generate the desired LCD

voltage. This method results in higher power consumption but can result in better results when driving TN displays. LCD operation is supported during Deep Sleep refreshing a small display buffer (4 bits; 1 32-bit register per port).

CapSense

CapSense is supported on all pins in the PSoC 4100 through a CapSense Sigma-Delta (CSD) block that can be connected to any pin through an analog mux bus that any GPIO pin can be connected to via an Analog switch. CapSense function can thus be provided on any pin or group of pins in a system under software control. A component is provided for the CapSense block to make it easy for the user.

Shield voltage can be driven on another mux bus to provide water tolerance capability. Water tolerance is provided by driving the shield electrode in phase with the sense electrode to keep the shield capacitance from attenuating the sensed input.

The CapSense block has two IDACs which can be used for general purposes if CapSense is not being used. (both IDACs are available in that case) or if CapSense is used without water tolerance (one IDAC is available).

WLCSP Package Bootloader

The WLCSP package is supplied with an I²C Bootloader installed in flash. The bootloader is compatible with PSoC Creator bootloadable project files and has the following default settings:

- I²C SCL and SDA connected to port pins P4.0 and P4.1 respectively (external pull-up resistors required)
- I²C Slave mode, address 8, data rate = 100 kbps
- Single application
- Wait two seconds for bootload command
- Other bootloader options are as set by the PSoC Creator Bootloader Component default
- Occupies the bottom 4.5 K of flash

For more information on this bootloader, see the following Cypress application notes:

AN73854 - Introduction to Bootloaders

Note that a PSoC Creator bootloadable project must be associated with .hex and .elf files for a bootloader project that is configured for the target device. Bootloader .hex and .elf files can be found at http://www.cypress.com/?rID=78805. The factory-installed bootloader can be overwritten using JTAG or SWD programming.



Pinouts

The following is the pin-list for PSoC 4100 (44-TQFP, 40-QFN, 28-SSOP, and 48-TQFP). Port 2 comprises of the high-speed Analog inputs for the SAR Mux. P1.7 is the optional external input and bypass for the SAR reference. Ports 3 and 4 contain the Digital Communication channels. All pins support CSD CapSense and analog mux bus connections.

44	4-TQFP	40	40-QFN 28-S		3-SSOP	48	3-TQFP		Alte	ernate Functions f	or Pins		Dia Description
Pin	Name	Pin	Name	Pin	Name	Pin	Name	Analog	Alt 1	Alt 2	Alt 3	Alt 4	- Pin Description
1	VSS	-	-	-	-	-	-	-	_	-	-	_	Ground
2	P2.0	1	P2.0	-	-	2	P2.0	sarmux.0	-	-	-	_	Port 2 Pin 0: gpio, lcd, csd, sarmux
3	P2.1	2	P2.1	-	-	3	P2.1	sarmux.1	-	-	-	_	Port 2 Pin 1: gpio, lcd, csd, sarmux
4	P2.2	3	P2.2	5	P2.2	4	P2.2	sarmux.2	-	-	-	_	Port 2 Pin 2: gpio, lcd, csd, sarmux
5	P2.3	4	P2.3	6	P2.3	5	P2.3	sarmux.3	-	-	-	_	Port 2 Pin 3: gpio, lcd, csd, sarmux
6	P2.4	5	P2.4	7	P2.4	6	P2.4	sarmux.4	tcpwm0_p[1]	-			Port 2 Pin 4: gpio, lcd, csd, sarmux, pwm
7	P2.5	6	P2.5	8	P2.5	7	P2.5	sarmux.5	tcpwm0_n[1]	-	-	_	Port 2 Pin 5: gpio, lcd, csd, sarmux, pwm
8	P2.6	7	P2.6	9	P2.6	8	P2.6	sarmux.6	tcpwm1_p[1]	-	-	_	Port 2 Pin 6: gpio, lcd, csd, sarmux, pwm
9	P2.7	8	P2.7	10	P2.7	9	P2.7	sarmux.7	tcpwm1_n[1]	-	-	_	Port 2 Pin 7: gpio, lcd, csd, sarmux, pwm
10	VSS	9	VSS	-	-	-	-	-	-	-	-	_	Ground
-	-	-	-	-	-	10	NC	-	-	-	-	_	No Connect
-	-	1	-	-	-	11	NC	-	-	-	-	-	No Connect
11	P3.0	10	P3.0	11	P3.0	12	P3.0	-	tcpwm0_p[0]	scb1_uart_rx[0]	scb1_i2c_scl[0]	scb1_spi_mosi[0]	Port 3 Pin 0: gpio, lcd, csd, pwm, scb1
12	P3.1	11	P3.1	12	P3.1	13	P3.1	-	tcpwm0_n[0]	scb1_uart_tx[0]	scb1_i2c_sda[0]	scb1_spi_miso[0]	Port 3 Pin 1: gpio, lcd, csd, pwm, scb1
13	P3.2	12	P3.2	13	P3.2	14	P3.2	-	tcpwm1_p[0]	_	swd_io[0]	scb1_spi_clk[0]	Port 3 Pin 2: gpio, lcd, csd, pwm, scb1, swd
-	-	-	-	-	-	15	VSSD	-	-	-	-	_	Ground
14	P3.3	13	P3.3	14	P3.3	16	P3.3	-	tcpwm1_n[0]	-	swd_clk[0]	scb1_spi_ssel_0[0]	Port 3 Pin 3: gpio, lcd, csd, pwm, scb1, swd
15	P3.4	14	P3.4	-	-	17	P3.4	-	tcpwm2_p[0]	-	-	scb1_spi_ssel_1	Port 3 Pin 4: gpio, lcd, csd, pwm, scb1
16	P3.5	15	P3.5	-	-	18	P3.5	-	tcpwm2_n[0]	-	-	scb1_spi_ssel_2	Port 3 Pin 5: gpio, lcd, csd, pwm, scb1
17	P3.6	16	P3.6	-	-	19	P3.6	-	tcpwm3_p[0]	_	swd_io[1]	scb1_spi_ssel_3	Port 3 Pin 6: gpio, lcd, csd, pwm, scb1, swd
18	P3.7	17	P3.7	-	-	20	P3.7	-	tcpwm3_n[0]	-	swd_clk[1]	_	Port 3 Pin 7: gpio, lcd, csd, pwm, swd
19	VDDD	-	-	-	-	21	VDDD	-	-	-	-	_	Digital Supply, 1.8 - 5.5V
20	P4.0	18	P4.0	15	P4.0	22	P4.0	-	-	scb0_uart_rx	scb0_i2c_scl	scb0_spi_mosi	Port 4 Pin 0: gpio, lcd, csd, scb0
21	P4.1	19	P4.1	16	P4.1	23	P4.1	_	-	scb0_uart_tx	scb0_i2c_sda	scb0_spi_miso	Port 4 Pin 1: gpio, lcd, csd, scb0
22	P4.2	20	P4.2	17	P4.2	24	P4.2	csd_c_mod	_	-	-	scb0_spi_clk	Port 4 Pin 2: gpio, lcd, csd, scb0
23	P4.3	21	P4.3	18	P4.3	25	P4.3	csd_c_sh_tank	-	-	-	scb0_spi_ssel_0	Port 4 Pin 3: gpio, lcd, csd, scb0
_	-	_	-	-	-	26	NC	_	-	_	-	-	No Connect
_		_	-	-	-	27	NC	_	-	_	-	-	No Connect

Document Number: 001-87220 Rev. *H



4	4-TQFP	4	0-QFN	2	8-SSOP	48	8-TQFP		Alte	rnate Functions f	or Pins		Din Decerintien
Pin	Name	Pin	Name	Pin	Name	Pin	Name	Analog	Alt 1	Alt 2	Alt 3	Alt 4	- Pin Description
24	P0.0	22	P0.0	19	P0.0	28	P0.0	comp1_inp	-	-	-	scb0_spi_ssel_1	Port 0 Pin 0: gpio, lcd, csd, scb0, comp
25	P0.1	23	P0.1	20	P0.1	29	P0.1	comp1_inn	-	-	-	scb0_spi_ssel_2	Port 0 Pin 1: gpio, lcd, csd, scb0, comp
26	P0.2	24	P0.2	21	P0.2	30	P0.2	comp2_inp	-	-	-	scb0_spi_ssel_3	Port 0 Pin 2: gpio, lcd, csd, scb0, comp
27	P0.3	25	P0.3	22	P0.3	31	P0.3	comp2_inn	-	-	-	_	Port 0 Pin 3: gpio, lcd, csd, comp
28	P0.4	26	P0.4	-	-	32	P0.4	-	-	scb1_uart_rx[1]	scb1_i2c_scl[1]	scb1_spi_mosi[1]	Port 0 Pin 4: gpio, lcd, csd, scb1
29	P0.5	27	P0.5	-	-	33	P0.5	-	-	scb1_uart_tx[1]	scb1_i2c_sda[1]	scb1_spi_miso[1]	Port 0 Pin 5: gpio, lcd, csd, scb1
30	P0.6	28	P0.6	23	P0.6	34	P0.6	-	ext_clk	-	-	scb1_spi_clk[1]	Port 0 Pin 6: gpio, lcd, csd, scb1, ext_clk
31	P0.7	29	P0.7	24	P0.7	35	P0.7	-	-	-	wakeup	scb1_spi_ssel_0[1]	Port 0 Pin 7: gpio, lcd, csd, scb1, wakeup
32	XRES	30	XRES	25	XRES	36	XRES	-	-	-	-	_	Chip reset, active low
33	VCCD	31	VCCD	26	VCCD	37	VCCD	-	-	-	-	-	Regulated supply, connect to 1µF cap or 1.8V
-	-	-	-	-	-	38	VSSD	-	-	-	-	-	Digital Ground
34	VDDD	32	VDDD	27	VDD	39	VDDD	-	-	-	-	_	Digital Supply, 1.8 - 5.5V
35	VDDA	33	VDDA	27	VDD	40	VDDA	_	_	-	-	_	Analog Supply, 1.8 - 5.5V, equal to VDDD
36	VSSA	34	VSSA	28	VSS	41	VSSA	_	_	-	-	_	Analog Ground
37	P1.0	35	P1.0	1	P1.0	42	P1.0	ctb.oa0.inp	tcpwm2_p[1]	-	-	_	Port 1 Pin 0: gpio, lcd, csd, ctb, pwm
38	P1.1	36	P1.1	2	P1.1	43	P1.1	ctb.oa0.inm	tcpwm2_n[1]	-	-	_	Port 1 Pin 1: gpio, lcd, csd, ctb, pwm
39	P1.2	37	P1.2	3	P1.2	44	P1.2	ctb.oa0.out	tcpwm3_p[1]	-	-	-	Port 1 Pin 2: gpio, lcd, csd, ctb, pwm
40	P1.3	38	P1.3	-	-	45	P1.3	ctb.oa1.out	tcpwm3_n[1]	-	-	-	Port 1 Pin 3: gpio, lcd, csd, ctb, pwm
41	P1.4	39	P1.4	_	_	46	P1.4	ctb.oa1.inm	_	-	-	_	Port 1 Pin 4: gpio, lcd, csd, ctb
42	P1.5	-	-	-	-	47	P1.5	ctb.oa1.inp	-	-	-	-	Port 1 Pin 5: gpio, lcd, csd, ctb
43	P1.6	-	_	1	_	48	P1.6	ctb.oa0.inp_alt	-	-	-	ı	Port 1 Pin 6: gpio, lcd, csd
44	P1.7/VREF	40	P1.7/VREF	4	P1.7/VREF	1	P1.7/VREF	ctb.oa1.inp_alt ext_vref	-	-	-	_	Port 1 Pin 7: gpio, lcd, csd, ext_ref

Notes:

- 1. tcpwm_p and tcpwm_n refer to tcpwm non-inverted and inverted outputs respectively.
- 2. P3.2 and P3.3 are SWD pins after boot (reset).



35-	Ball CSP		Alte	rnate Functions	for Pins		Pin Description
Pin	Name	Analog	Alt 1	Alt 2	Alt 3	Alt 4	r iii Description
C6	P1.2	ctb.oa0.out	tcpwm3_p[1]	_	_	_	Port 1 Pin 2: gpio, lcd, csd, ctb, pwm
D7	P1.3	ctb.oa1.out	tcpwm3_n[1]	_	-	-	Port 1 Pin 3: gpio, lcd, csd, ctb, pwm
D4	P1.4	ctb.oa1.inm	_	_	_	_	Port 1 Pin 4: gpio, lcd, csd, ctb
D5	P1.5	ctb.oa1.inp	_	_	_	_	Port 1 Pin 5: gpio, lcd, csd, ctb
D6	P1.6	ctb.oa0.inp_alt	_	_	_	_	Port 1 Pin 6: gpio, lcd, csd
E7	P1.7/VREF	ctb.oa1.inp_alt ext_vref	-	-	-	-	Port 1 Pin 7: gpio, lcd, csd, ext_ref

Descriptions of the Pin functions are as follows:

VDDD: Power supply for both analog and digital sections (where there is no V_{DDA} pin).

VDDA: Analog V_{DD} pin where package pins allow; shorted to V_{DDD} otherwise.

VSSA: Analog ground pin where package pins allow; shorted to VSS otherwise

VSS: Ground pin.

VCCD: Regulated Digital supply (1.8 V ±5%).

Port Pins can all be used as LCD Commons, LCD Segment drivers, or CSD sense and shield pins can be connected to AMUXBUS A or B or can all be used as GPIO pins that can be driven by firmware or DSI signals.

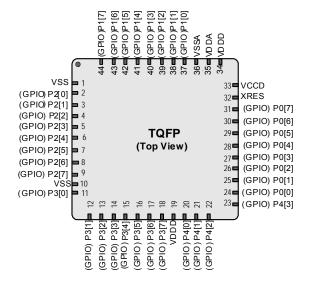
The following packages are supported: 48-pin TQFP, 44-pin TQFP, 40-pin QFN, and 28-pin SSOP.

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(GPIO) P1.6 (GPIO) P1.5 (GPIO) P1.4 (GPIO) P1.3 (GPIO) P1.1 (GPIO) P1.0 (GPIO) P1.2 (GPIO) (G (GPIO)P1.7/VREF 1 XRES (GPIO) P2.0 2 35 GPIO) P0.7 (GPIO) P2.1 34 GPIO) P0.6 (GPIO) P2.2 33 GPIO) P0.5 (GPIO) P2.3 32 GPIO) P0.4 **48 TQFP** (GPIO) P2.4 (GPIO) P0.3 **Top View** (GPIO) P2.5 30 GPIO) P0.2 29 GPIO) P0.1 (GPIO) P2.6 (GPIO) P2.7 28 GPIO) P0.0 NC NC NC NC 25 GPIO) P4.3 (GPIO) P3.0 12 (GPIO) P4.0 (GPIO) P4.1 (GPIO) P3.2 (GPIO) P3.3 (GPIO) P3.4 (GPIO) P3.5 (GPIO) P3.6 (GPIO) P3.7 (GPIO) P4.2 (GPIO) P3.1

Figure 5. 48-Pin TQFP Pinout

Figure 6. 44-pin TQFP Part Pinout





Note It is good practice to check the datasheets for your bypass capacitors, specifically the working voltage and the DC bias specifications. With some capacitors, the actual capacitance can decrease considerably when the DC bias $(V_{DDA}, V_{DDD}, \text{ or } V_{CCD})$ is a significant percentage of the rated working voltage. V_{DDA} must be equal to or higher than the V_{DDD} supply when powering up.

Figure 13. 40-pin QFN Example

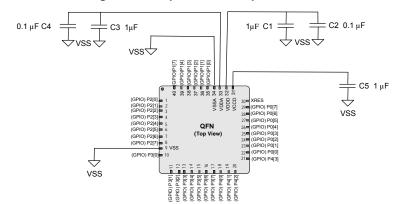
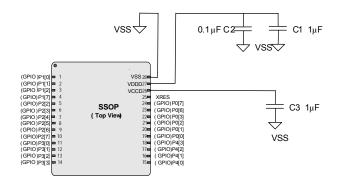


Figure 14. 28-SSOP Example



Regulated External Supply

In this mode, the PSoC 4100 is powered by an external power supply that must be within the range of 1.71 V to 1.89 V (1.8 \pm 5%); note that this range needs to include power supply ripple too. In this mode, VCCD, VDDA, and VDDD pins are all shorted together and bypassed. The internal regulator is disabled in firmware.



Electrical Specifications

Absolute Maximum Ratings

Table 1. Absolute Maximum Ratings^[1]

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID1	V _{DDD_ABS}	Digital supply relative to V _{SSD}	-0.5	_	6	V	Absolute max
SID2	V _{CCD_ABS}	Direct digital core voltage input relative to Vssd	-0.5	-	1.95	V	Absolute max
SID3	V _{GPIO_ABS}	GPIO voltage	-0.5	_	V _{DD} +0.5	V	Absolute max
SID4	I _{GPIO_ABS}	Maximum current per GPIO	-25	_	25	mA	Absolute max
SID5	I _{GPIO_injection}	GPIO injection current, Max for $V_{IH} > V_{DDD}$, and Min for $V_{IL} < V_{SS}$	-0.5	_	0.5	mA	Absolute max, current injected per pin
BID44	ESD_HBM	Electrostatic discharge human body model	2200	-	_	V	
BID45	ESD_CDM	Electrostatic discharge charged device model	500	_	_	V	
BID46	LU	Pin current for latch-up	-200	_	200	mA	

Device-Level Specifications

All specifications are valid for -40 °C \leq TA \leq 105 °C and TJ \leq 125 °C, except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted.

Table 2. DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID53	V_{DD}	Power Supply Input Voltage ($V_{DDA} = V_{DDD} = V_{DD}$)	1.8	-	5.5	V	With regulator enabled
SID255	V_{DDD}	Power Supply Input Voltage unregulated	1.71	1.8	1.89	V	Internally unregulated Supply
SID54	V_{CCD}	Output voltage (for core logic)	-	1.8	-	V	
SID55	CEFC	External Regulator voltage bypass	1	1.3	1.6	μF	X5R ceramic or better
SID56	CEXC	Power supply decoupling capacitor	_	1	_	μF	X5R ceramic or better
Active Mo	de, V _{DD} = 1.71	V to 5.5 V. Typical Values measured a	t V _{DD} = 3.	.3 V	•		
SID9	IDD4	Execute from Flash; CPU at 6 MHz	_	_	2.8	mA	
SID10	IDD5	Execute from Flash; CPU at 6 MHz	_	2.2	_	mA	T = 25 °C
SID12	IDD7	Execute from Flash; CPU at 12 MHz,	_	_	4.2	mA	
SID13	IDD8	Execute from Flash; CPU at 12 MHz	-	3.7	-	mA	T = 25 °C
SID16	IDD11	Execute from Flash; CPU at 24 MHz	_	6.7	_	mA	T = 25 °C
SID17	IDD12	Execute from Flash; CPU at 24 MHz	_	_	7.2	mA	
Sleep Mod	le, V _{DD} = 1.7 V	to 5.5 V			•		
SID25	IDD20	I ² C wakeup, WDT, and Comparators on. 6 MHz.	-	1.3	1.8	mA	V _{DD} = 1.71 to 5.5 V
SID25A	IDD20A	I ² C wakeup, WDT, and Comparators on. 12 MHz.	-	1.7	2.2	mA	V _{DD} = 1.71 to 5.5 V
Deep Slee	p Mode, V _{DD} =	1.8 V to 3.6 V (Regulator on)				•	
SID31	IDD26	I ² C wakeup and WDT on.	_	1.3	-	μΑ	T = 25 °C
SID32	IDD27	I ² C wakeup and WDT on.	_	_	45	μΑ	T = 85 °C

Note

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Usage above the absolute maximum conditions listed in Table 1 may cause permanent damage to the device. Exposure to absolute maximum conditions for extended
periods of time may affect device reliability. The maximum storage temperature is 150 °C in compliance with JEDEC Standard JESD22-A103, High Temperature
Storage Life. When used below absolute maximum conditions but above normal operating conditions, the device may not operate to specification.



Table 8. Opamp Specifications (Guaranteed by Characterization) (continued)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID297	Cload	Stable up to maximum load. Performance specs at 50 pF.	-	ı	125	pF	
SID298	Slew_rate	Cload = 50 pF, Power = High, V _{DDA} ≥ 2.7 V	6	-	_	V/µs	
SID299	T_op_wake	From disable to enable, no external RC dominating	_	300	_	μs	
SID299A	OL_GAIN	Open Loop Gain	_	90	_	dB	Guaranteed by design
	Comp_mode	Comparator mode; 50-mV drive, Trise = Tfall (approx)	_	-	_		
SID300	T _{PD1}	Response time; power = high	_	150	_	ns	
SID301	T _{PD2}	Response time; power = medium	_	400	_	ns	
SID302	T _{PD3}	Response time; power = low	_	2000	_	ns	
SID303	Vhyst_op	Hysteresis	-	10	ı	mV	

Comparator

Table 9. Comparator DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID85	V _{OFFSET2}	Input offset voltage, Common Mode voltage range from 0 to V _{DD} -1	-	_	±4	mV	
SID85A	V _{OFFSET3}	Input offset voltage. Ultra low-power mode ($V_{DDD} \ge 2.2 \text{ V for Temp} < 0 ^{\circ}\text{C}$, $V_{DDD} \ge 1.8 \text{ V for Temp} > 0 ^{\circ}\text{C}$)	_	±12	_	mV	
SID86	V _{HYST}	Hysteresis when enabled, Common Mode voltage range from 0 to V _{DD} -1.	_	10	35	mV	Guaranteed by characterization
SID87	V _{ICM1}	Input common mode voltage in normal mode	0	_	V _{DDD} – 0.1	V	Modes 1 and 2.
SID247	V _{ICM2}	Input common mode voltage in low power mode (V _{DDD} ≥ 2.2 V for Temp < 0 °C, V _{DDD} ≥ 1.8 V for Temp > 0 °C)	0	_	V _{DDD}	V	
SID247A	V _{ICM3}	Input common mode voltage in ultra low power mode	0	_	V _{DDD} – 1.15	V	
SID88	CMRR	Common mode rejection ratio	50	_	_	dB	V _{DDD} ≥ 2.7 V. Guaranteed by characterization
SID88A	CMRR	Common mode rejection ratio	42	_	_	dB	V _{DDD} < 2.7 V. Guaranteed by characterization
SID89	I _{CMP1}	Block current, normal mode	-	_	400	μΑ	Guaranteed by characterization
SID248	I _{CMP2}	Block current, low power mode	_	_	100	μΑ	Guaranteed by characterization
SID259	I _{CMP3}	Block current, ultra low power mode $(V_{DDD} \ge 2.2 \text{ V for Temp} < 0 \text{ °C}, V_{DDD} \ge 1.8 \text{ V for Temp} > 0 \text{ °C})$	-	6	28	μA	Guaranteed by characterization
SID90	Z _{CMP}	DC input impedance of comparator	35	_	_	ΜΩ	Guaranteed by characterization

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Table 12. SAR ADC DC Specifications (continued)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID111B	A_INL	Integral non linearity	-1.5	-	+1.7	LSB	V _{DDD} = 1.71 to 5.5, 500 ksps, V _{REF} = 1 to 5.5.
SID112	A_DNL	Differential non linearity	-1	_	+2.2	LSB	V _{DDD} = 1.71 to 5.5, 806 ksps, V _{REF} = 1 to 5.5.
SID112A	A_DNL	Differential non linearity	-1	1	+2	LSB	V _{DDD} = 1.71 to 3.6, 806 ksps, V _{REF} = 1.71 to V _{DDD} .
SID112B	A_DNL	Differential non linearity	-1	-	+2.2	LSB	V _{DDD} = 1.71 to 5.5, 500 ksps, V _{REF} = 1 to 5.5.

Table 13. SAR ADC AC Specifications (Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID108	A_SAMP_1	Sample rate with external reference bypass cap	_	_	806	ksps	
SID108A	A_SAMP_2	Sample rate with no bypass cap. Reference = V _{DD}	_	_	500	ksps	
SID108B	A_SAMP_3	Sample rate with no bypass cap. Internal reference	_	_	100	ksps	
SID109	A_SNDR	Signal-to-noise and distortion ratio (SINAD)	65	-	_	dB	F _{IN} = 10 kHz
SID113	A_THD	Total harmonic distortion	-	_	-65	dB	F _{IN} = 10 kHz.

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Memory

Table 26. Flash DC Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID173	V _{PE}	Erase and program voltage	1.71	1	5.5	V	

Table 27. Flash AC Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID174	T _{ROWWRITE} ^[3]	Row (block) write time (erase and program)	_	_	20	ms	Row (block) = 128 bytes
SID175	T _{ROWERASE} ^[3]	Row erase time	_	_	13	ms	
SID176	T _{ROWPROGRAM} ^[3]	Row program time after erase	1	1	7	ms	
SID178	T _{BULKERASE} ^[3]	Bulk erase time (32 KB)	1	1	35	ms	
SID180	T _{DEVPROG} ^[3]	Total device program time	1	1	7	seconds	Guaranteed by characterization
SID181	F _{END}	Flash endurance	100 K	_	-	cycles	Guaranteed by characterization
SID182	F _{RET}	Flash retention. $T_A \le 55$ °C, 100 K P/E cycles	20	_	_	years	Guaranteed by characterization
SID182A		Flash retention. $T_A \le 85$ °C, 10 K P/E cycles	10	_	_	years	Guaranteed by characterization
SID182B	F _{RETQ}	Flash retention. T _A ≤ 105 °C, 10 K P/E cycles, ≤ three years at TA ≥ 85 °C	10	_	20	years	Guaranteed by characterization

System Resources

Power-on-Reset (POR) with Brown Out

Table 28. Imprecise Power On Reset (IPOR)

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID185	V _{RISEIPOR}	Rising trip voltage	0.80	_	1.45	V	Guaranteed by characterization
SID186	V _{FALLIPOR}	Falling trip voltage	0.75	_	1.4	V	Guaranteed by characterization
SID187	V _{IPORHYST}	Hysteresis	15	_	200	mV	Guaranteed by characterization

Table 29. Precise Power On Reset (POR)

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID190	V _{FALLPPOR}	BOD trip voltage in active and sleep modes	1.64	-	_		Full functionality between 1.71 V and BOD trip voltage is guaranteed by characterization
SID192	V _{FALLDPSLP}	BOD trip voltage in Deep Sleep	1.4	_	_	V	Guaranteed by characterization
BID55	Svdd	Maximum power supply ramp rate	_	_	67	kV/sec	

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Note
3. It can take as much as 20 milliseconds to write to Flash. During this time the device should not be Reset, or Flash operations will be interrupted and cannot be relied on to have completed. Reset sources include the XRES pin, software resets, CPU lockup states and privilege violations, improper power supply levels, and watchdogs. Make certain that these are not inadvertently activated.



Table 38. Block Specs

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID257	T _{WS24} *	Number of wait states at 24 MHz	0	-	-		CPU execution from Flash. Guaranteed by characterization
SID260	V _{REFSAR}	Trimmed internal reference to SAR	– 1	-	+1	%	Percentage of Vbg (1.024 V). Guaranteed by characterization
SID262	T _{CLKSWITCH}	Clock switching from clk1 to clk2 in clk1 periods	3	_	4	Periods	Guaranteed by design
* Tws24 is gr	uaranteed by Design					I.	

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Ordering Information

The PSoC 4100 part numbers and features are listed in the following table.

Table 39. PSoC 4100 Family Ordering Information

Table	Features								Package									
Family	MPN	Max CPU Speed (MHz)	Flash (KB)	SRAM (KB)	NDB	Op-amp (CTBm)	CapSense	Direct LCD Drive	12-bit SAR ADC	LP Comparators	TCPWM Blocks	SCB Blocks	GPIO	28-SSOP	35-WLCSP	40-QFN	44-TQFP	48-TQFP
	CY8C4124PVI-432	24	16	4	-	1	-	-	806 ksps	2	4	2	24	√				
	CY8C4124PVI-442	24	16	4	-	1	V	√	806 ksps	2	4	2	24	V				
	CY8C4124PVQ-432	24	16	4	-	1	-	-	806 ksps	2	4	2	24	1				
	CY8C4124PVQ-442	24	16	4	-	1	V	V	806 ksps	2	4	2	24	V				
	CY8C4124FNI-443	24	16	4	-	2	V	V	806 ksps	2	4	2	31		V			
	CY8C4124LQI-443	24	16	4	-	2	V	V	806 ksps	2	4	2	34			V		
	CY8C4124AXI-443	24	16	4	-	2	V	1	806 ksps	2	4	2	36				1	
	CY8C4124LQQ-443	24	16	4	-	2	V	1	806 ksps	2	4	2	34			1		
	CY8C4124AXQ-443	24	16	4	-	2	V	V	806 ksps	2	4	2	36				1	
	CY8C4124AZI-443	24	16	4	-	2	V	1	806 ksps	2	4	2	36					√
4100	CY8C4125AXI-473	24	32	4	-	2	-	-	806 ksps	2	4	2	36				1	
4	CY8C4125AXQ-473	24	32	4	-	2	-	-	806 ksps	2	4	2	36				V	
	CY8C4125AZI-473	24	32	4	-	2	-	-	806 ksps	2	4	2	36					√
	CY8C4125PVI-482	24	32	4	-	1	V	V	806 ksps	2	4	2	24	V				
	CY8C4125PVQ-482	24	32	4	-	1	V	V	806 ksps	2	4	2	24	V				
	CY8C4125FNI-483(T)	24	32	4	-	2	V	V	806 ksps	2	4	2	31		V			
	CY8C4125LQI-483	24	32	4	-	2	V	√	806 ksps	2	4	2	34			1		
	CY8C4125AXI-483	24	32	4	-	2	V	V	806 ksps	2	4	2	36				1	
	CY8C4125LQQ-483	24	32	4	-	2	√	√	806 ksps	2	4	2	34			V		
	CY8C4125AXQ-483	24	32	4	-	2	V	V	806 ksps	2	4	2	36				V	
	CY8C4125AZI-483	24	32	4	-	2	√	V	806 ksps	2	4	2	36					V

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7.50
8.10

DIMENSIONS IN MILLIMETERS MIN.
MAX.

SEATING PLANE

2.00
MAX.

0° MIN.

GAUGE PLANE

2.00
MAX.

0° MIN.

GAUGE PLANE

0° MIN.

GAUGE PLANE

0.65 BSC.

3.65
1.85

GAUGE PLANE

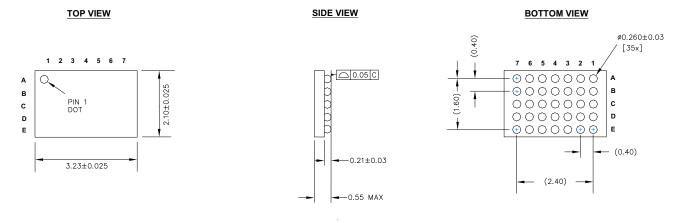
0.025

1.25 REF-

- <u>0.55</u> 0.95

Figure 15. 28-pin (210-mil) SSOP Package Outline

Figure 16. 35-ball WLCSP Package Outline



NOTES:

- 1. REFERENCE JEDEC PUBLICATION 95, DESIGN GUIDE 4.18
- 2. ALL DIMENSIONS ARE IN MILLIMETERS

001-93741 **

51-85079 *F



Acronyms

Table 43. Acronyms Used in this Document

Acronym	Description
abus	analog local bus
ADC	analog-to-digital converter
AG	analog global
АНВ	AMBA (advanced microcontroller bus architecture) high-performance bus, an ARM data transfer bus
ALU	arithmetic logic unit
AMUXBUS	analog multiplexer bus
API	application programming interface
APSR	application program status register
ARM [®]	advanced RISC machine, a CPU architecture
ATM	automatic thump mode
BW	bandwidth
CAN	Controller Area Network, a communications protocol
CMRR	common-mode rejection ratio
CPU	central processing unit
CRC	cyclic redundancy check, an error-checking protocol
DAC	digital-to-analog converter, see also IDAC, VDAC
DFB	digital filter block
DIO	digital input/output, GPIO with only digital capabilities, no analog. See GPIO.
DMIPS	Dhrystone million instructions per second
DMA	direct memory access, see also TD
DNL	differential nonlinearity, see also INL
DNU	do not use
DR	port write data registers
DSI	digital system interconnect
DWT	data watchpoint and trace
ECC	error correcting code
ECO	external crystal oscillator
EEPROM	electrically erasable programmable read-only memory
EMI	electromagnetic interference
EMIF	external memory interface
EOC	end of conversion
EOF	end of frame
EPSR	execution program status register
ESD	electrostatic discharge

Table 43. Acronyms Used in this Document (continued)

ETM embedded trace macrocell FIR finite impulse response, see also IIR FPB flash patch and breakpoint FS full-speed GPIO general-purpose input/output, applies to a PSoC pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I²C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also HVI LVTTL low-voltage transistor-transistor logic	Acronym	Description
FPB flash patch and breakpoint FS full-speed GPIO general-purpose input/output, applies to a PSoCpin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I²C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also HVI	ETM	embedded trace macrocell
FS full-speed GPIO general-purpose input/output, applies to a PSoC pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I²C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also HVI LVI low-voltage interrupt, see also HVI	FIR	finite impulse response, see also IIR
GPIO general-purpose input/output, applies to a PSoC pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I ² C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also HVI LVI low-voltage interrupt, see also HVI	FPB	flash patch and breakpoint
pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I ² C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	FS	full-speed
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INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	ILO	internal low-speed oscillator, see also IMO
I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	IMO	internal main oscillator, see also ILO
IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	INL	integral nonlinearity, see also DNL
IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	I/O	input/output, see also GPIO, DIO, SIO, USBIO
IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	IPOR	initial power-on reset
ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	IPSR	interrupt program status register
LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	IRQ	interrupt request
LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	ITM	instrumentation trace macrocell
protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	LCD	liquid crystal display
LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	LIN	
LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI	LR	link register
LVI low-voltage interrupt, see also HVI	LUT	lookup table
<u> </u>	LVD	low-voltage detect, see also LVI
LVTTL low-voltage transistor-transistor logic	LVI	low-voltage interrupt, see also HVI
	LVTTL	low-voltage transistor-transistor logic
MAC multiply-accumulate	MAC	multiply-accumulate
MCU microcontroller unit	MCU	microcontroller unit
MISO master-in slave-out	MISO	master-in slave-out
NC no connect	NC	no connect
NMI nonmaskable interrupt	NMI	nonmaskable interrupt
NRZ non-return-to-zero	NRZ	non-return-to-zero
NVIC nested vectored interrupt controller	NVIC	nested vectored interrupt controller
NVL nonvolatile latch, see also WOL	NVL	nonvolatile latch, see also WOL
opamp operational amplifier	opamp	operational amplifier
PAL programmable array logic, see also PLD	PAL	programmable array logic, see also PLD

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Document Conventions

Units of Measure

Table 44. Units of Measure

Table 44. Units of Measure							
Symbol	Unit of Measure						
°C	degrees Celsius						
dB	decibel						
fF	femto farad						
Hz	hertz						
KB	1024 bytes						
kbps	kilobits per second						
Khr	kilohour						
kHz	kilohertz						
kΩ	kilo ohm						
ksps	kilosamples per second						
LSB	least significant bit						
Mbps	megabits per second						
MHz	megahertz						
ΜΩ	mega-ohm						
Msps	megasamples per second						
μΑ	microampere						
μF	microfarad						
μH	microhenry						
μs	microsecond						
μV	microvolt						
μW	microwatt						
mA	milliampere						
ms	millisecond						
mV	millivolt						
nA	nanoampere						
ns	nanosecond						
nV	nanovolt						
Ω	ohm						
pF	picofarad						
ppm	parts per million						
ps	picosecond						
s	second						
sps	samples per second						
sqrtHz	square root of hertz						
V	volt						
L							

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